Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination KONNO, HIROYUKI	
09/973,247		
Examiner	Art Unit	
Sang Nguyen	2877	

SEARCHED					
Class	Subclass	Date	Examiner		
356	600-624	4/26/2005	SN		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

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